## Application/Control No. Applicant(s)/Patent Under Reexamination 10/017,135 FOSTER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Simon J. Oh 1618 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,063,910 05-2000 Debenedetti et al. 530/418 Α US-В US-С US-D US-Е US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY WO 00/37169 06-2000 **WIPO** Merrified et al. Ν B01J 2/04 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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